

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	387	331/135.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/20 10:20
L2	535	331/143.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/20 10:21
L3	1125	331/57.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/20 10:21
L4	931	331/176.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/20 10:22
L5	1501	oscillat\$4 (cr or rc) feedback resistor capacitor trigger positive temperature	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2006/06/20 10:27
L6	288	oscillat\$4 (cr or rc) feedback resistor capacitor trigger positive temperature	US-PGPUB	AND	ON	2006/06/20 10:27
L7	0	(oscillat\$4 (cr or rc) feedback resistor capacitor trigger positive temperature).clm.	US-PGPUB	AND	ON	2006/06/20 10:27
L8	2	(oscillat\$4 (cr or rc) feedback resistor capacitor trigger temperature).clm.	US-PGPUB	AND	ON	2006/06/20 10:28
S1	83687	oscillator and (cr rc resistor capacitor) and (active transistor amplifier inverter)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/20 10:18
S2	79509	feedback same (cr rc resistor capacitor)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:59

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S3	20336	S1 and S2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:41
S4	31173	"331"/\$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:41
S5	2973	S3 and S4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:41
S6	403382	(temperature heat) near resist\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:43
S7	75	S5 and S6	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:28
S8	2745	semiconductor near resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:28
S9	18249	impurity near doped	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:29
S10	109	S8 and S9	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:30
S11	1	S7 and S10	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:29
S12	371	331/135.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:53

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S13	1016	331/57.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:55
S14	42	S12 and S13	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:53
S15	876	331/176.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:55
S16	0	S14 and S15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 17:55
S17	292	S6 and S8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:00
S18	21	S2 and S17	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:00
S19	3	S1 and S18	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:10
S20	19	oscillator and (temperature near coefficient near larger)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:28
S21	4	oscillator and (temperature near coefficient near larger) same resistor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:48
S22	28	331/57.ccls. and 331/176/.ccls. and (cr rc (resistor same capacitor))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:50

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S23	0	S20 and S22	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 18:51
S24	2	"5134371".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/04/29 05:39
S25	2	"5180995".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/04/29 05:39
S26	2	"20020000889"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/29 07:43
S27	37	("5012244" "6137372" "6385443" "6556159" "6646581" "20030016088" "6147567" "6400298" "20020135428" "5036294" "5200750" "6580376" "6750839" "RE38083" "6344814" "6590426" "20020008593" "5754072" "6515540").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/04/29 10:00